



Vishay Siliconix

# N-Channel 20-V (D-S) MOSFET

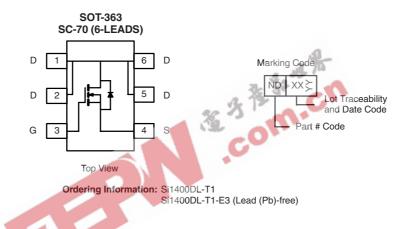
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$r_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A)			
- 20	0.150 at V <sub>GS</sub> = 4.5 V	1.7			
	0.235 at $V_{GS} = 2.5 \text{ V}$	1.3			

#### **FEATURES**

• TrenchFET® Power MOSFET: 2.5 V Rated







ABSOLUTE MAXIMUM RATINGS	T <sub>A</sub> = 25 °C, unle	ess otherwise	noted			
Parameter		Symbol	5 s	Steady State	Unit	
Drain-Source Voltage		V <sub>DS</sub>	20		V	
Gate-Source Voltage		V <sub>GS</sub>	± 12			
O-ation - David O-ation (T. 450.00)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	1.7	1.6	٨	
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 85 °C		1.2	1.0		
Pulsed Drain Current		I <sub>DM</sub>	5		Α	
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	0.8 0.8		l <sub>S</sub> 0.8	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 25 °C	- P <sub>D</sub>	0.625	0.568	W	
	T <sub>A</sub> = 85 °C		0.40	0.295		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Mariana Indiana Indiana	t ≤ 5 s	- R <sub>thJA</sub>	165	200	°C/W
Maximum Junction-to-Ambient <sup>a</sup>	Steady State		180	220	
Maximum Junction-to-Foot (Drain)	Steady State		105	130	

#### Notes:

a. Surface Mounted on 1" x 1" FR4 Board.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply.

### **Si1400DL**

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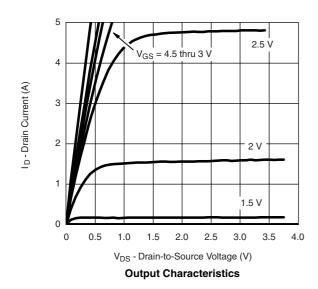
Parameter	Symbol	Test Conditions Min		Тур	Max	Unit	
Static	•						
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.6			V	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85 \text{ °C}$			1	μΑ	
					5		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	2			Α	
Drain-Source On-State Resistance <sup>a</sup>	r <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 1.7 \text{ A}$		0.123	0.150	0	
		$V_{GS} = 2.5 \text{ V}, I_D = 1.3 \text{ A}$		0.195	0.235	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.7 A		5		S	
Diode Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>S</sub> = 0.8 A, V <sub>GS</sub> = 0 V		0.78	1.1	V	
Dynamic <sup>b</sup>							
Total Gate Charge	$Q_g$			2.1	4.0	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1.7 \text{ A}$	-	0.3			
Gate-Drain Charge	$Q_{gd}$	40.00	-	0.4			
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 10 V, $R_L$ = 20 $\Omega$ $I_D \cong$ 1 A, $V_{GEN}$ = 4.5 V, $R_g$ = 6 $\Omega$		10	17		
Rise Time	t <sub>r</sub>	$V_{DD} = 10 \text{ V}, R_{L} = 20 \Omega$		30	50	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 6 \Omega$		14	25		
Fall Time	t <sub>f</sub>			8	15		
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	$I_{\rm F} = 0.8 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$		30	50		

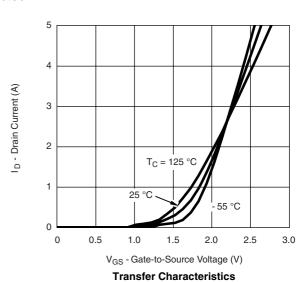
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



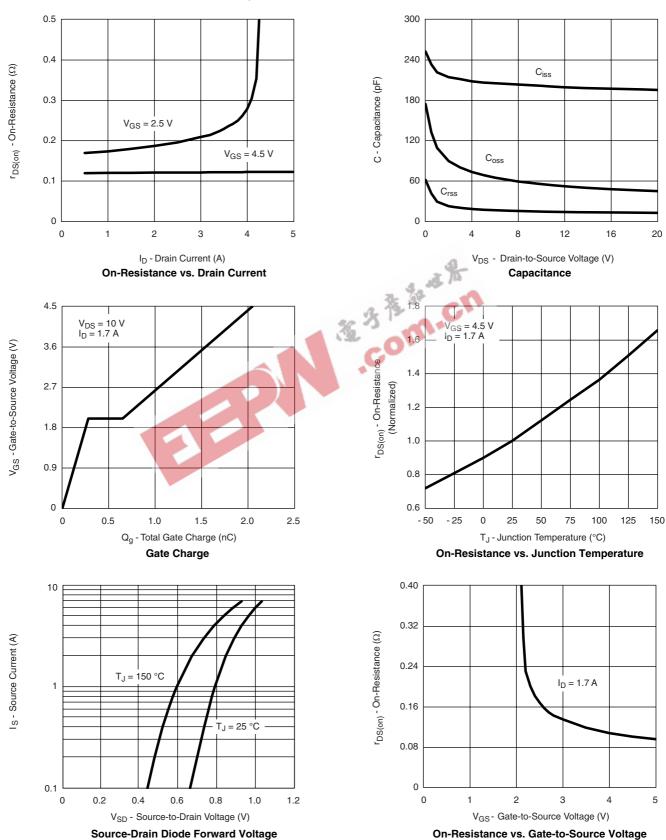






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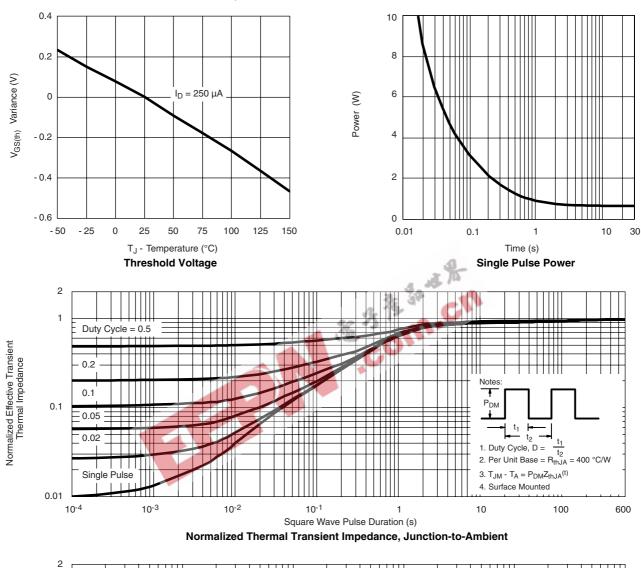


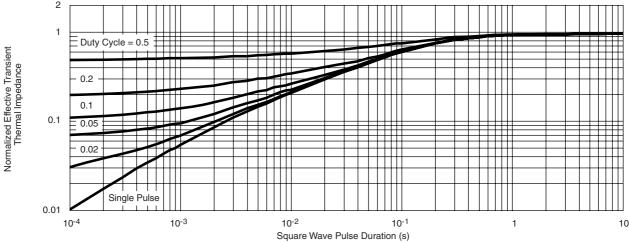
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Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?71179">https://www.vishay.com/ppg?71179</a>.





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